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Review of Conducting Oxides Semiconductors in Thin Solid Films

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ABSTRACT

The present review paper reports on the physical properties, status, prospects for further development, applications of polycrystalline or amorphous, transparent and conducting oxides (TCO) semiconductors. The coexistence of electrical conductivity and optical transparency in these materials depends on the nature, number, and atomic arrangements of metal cations in crystalline or amorphous oxide structures, on the resident morphology, and on the presence of intrinsic or intentionally introduced defects. The important TCO semiconductors are impurity doped ZnO, $\ln_2 O_3$, SnO_2 and CdO, as well as the ternary compounds $\mathrm{Zn}_2\mathrm{SnO}_4$, ZnSnO_3 , $\mathrm{Zn}_2\mathrm{In}_2\mathrm{O}_5$, $\mathrm{Zn}_3\mathrm{In}_2\mathrm{O}_6$, $\mathrm{In}_2\mathrm{SnO}_4$, CdSnO_3 , and multi-component oxides consisting of combinations of ZnO, $\mathrm{In}_2\mathrm{O}_3$ and SnO_2 . Sn doped $\mathrm{In}_2\mathrm{O}_3$ (ITO) and F doped SnO_2 TCO thin solid films are the preferable materials for most present applications. The expanding use of TCO materials, especially for the production of transparent electrodes for optoelectronic device applications, is endangered by the scarcity and high price of In.

This situation drives the search for alternative TCO materials to replace ITO. The electrical resistivity of the novel TCO materials should be $\sim \! 10^{-5} \rm Wcm$, typical absorption coefficient smaller than 10^4 cm $^{-1}$ in the near UV and visible range, with optical band gap $\sim \! 3$ eV. At present, ZnO:Al and ZnO:Ga (AZO and GZO) semiconductors could become good alternatives to ITO for thin-film transparent electrode applications. The best candidates are AZO thin solid films, which have low resistivity of the order of 10^{-4} Wcm, inexpensive source materials, and are non-toxic. However, development of large area deposition techniques is still needed to enable the production of AZO and GZO films on large area substrates with a high deposition rate. In addition to the required electrical and optical characteristics, applied TCO materials should be stable in hostile environment containing acidic and alkali solutions, oxidizing and reducing atmospheres, and elevated temperature. Most of the TCO materials are n-type semiconductors, but p-type TCO materials are researched and developed. Such TCO include: ZnO:Mg, ZnO:N, IZO, NiO, NiO:Li, CuAlO $_2$, Cu $_2$ SrO $_2$, and CuGaO $_2$ thin solid films. At present, these materials have not yet found place in actual applications.

Introduction

Most optically transparent and electrically conducting oxides (TCO) are binary or ternary compounds, containing one or two metallic elements. Their resistivity could be as low as 10^{-4} Wcm, and their extinction coefficient k in the optical visible range (VIS)

could be lower than 0.0001, owing to their wide optical band gap (Eg) that could be greater than 3 eV. This remarkable combination of conductivity and transparency is usually impossible in intrinsic stoichiometric oxides; however, it is achieved by producing

them with a non-stoichiometric composition or by introducing appropriate dopants. Badeker (1907) discovered that thin CdO films possess such characteristics [1]. Later, it was recognized that thin solid films of ZnO, SnO $_2$, In $_2$ O $_3$ and their alloys were also TCOs [2]. Doping these oxides resulted in improved electrical conductivity without degrading their optical transmission. Al doped ZnO (AZO), tin doped In $_2$ O $_3$, (ITO) and antimony or fluorine doped SnO2 (ATO and FTO), are among the most utilized TCO thin solid films in modern technology. In particular, ITO is used extensively.

The actual and potential applications of TCO thin solid films include:

- (1) Transparent electrodes for flat panel displays
- (2) Transparent electrodes for photovoltaic cells,
- (3) Low emissivity windows,
- (4) Window defrosters,
- (5) Transparent thin solid films transistors,
- (6) Light emitting diodes, and
- (7) Semiconductor lasers.

As the usefulness of TCO thin solid films depends on both their optical and electrical properties, both parameters should be considered together with environmental stability, abrasion resistance, electron work function, and compatibility with substrate and other components of a given device, as appropriate for the application. The availability of the raw materials and the economics of the deposition method are also significant factors in choosing the most appropriate TCO material. The selection decision is generally made by maximizing the functioning of the TCO thin film by considering all relevant parameters and minimizing the expenses. TCO material selection only based on maximizing the conductivity and the transparency can be faulty.

Recently, the scarcity and high price of Indium needed for ITO, the most popular TCO, as spurred R&D aimed at finding a substitute. Its electrical resistivity (ρ) should be $\sim \! 10^{\text{-4}} \text{Wcm}$ or less, with an absorption coefficient (α) smaller than 10^4 cm $^{-1}$ in the near-UV and VIS range, and with an optical band gap >3eV. A 100 nm thick film TCO film with these values for α and ρ will have optical transmission (T) 90% and a sheet resistance (R_s) 10 Ω At present, AZO and ZnO:Ga (GZO) semiconductors are promising alternatives to ITO for thin-film transparent electrode applications. The best candidates is AZO, which can have a low resistivity, e.g. on the order of 10^{-4} Wcm [3], and its source materials are inexpensive and nontoxic. However, the development of large area, high-rate deposition techniques is needed.

Another objective of the recent effort to develop novel TCO materials is to deposit p-type TCO films. Most of the TCO materials are n-type semiconductors, but p-type TCO materials are required for the development of solid lasers. Such p-type TCOs include: ZnO:Mg, ZnO:N, ZnO:In, NiO, NiO:Li, CuAlO₂, Cu₂SrO₂, and CuGaO₂ thin solid films. These materials have not yet found a place in actual applications. Published reviews on TCOs reported exhaustively on the deposition and diagnostic techniques, on film characteristics, and expected applications [4-6]. The present paper has three objectives:

- (1) To review the theoretical and experimental efforts to explore novel TCO materials intended to improve the TCO performance,
- (2) To explain the intrinsic physical limitations that affect the development of an alternative TCO with properties equivalent to those of ITO, and
- (3) To review the practical and industrial applications of existing TCO thin solid films.

Electrical Conductivity

TCOs are wide band gap (E $_g$) semiconducting oxides, with conductivity σ in the range 10^2 – 1.2×10^6 (S). The conductivity is due to doping either by oxygen vacancies or by extrinsic dopants. In the absence of doping, these oxides become very good insulators, with $\rho > 10^{10}\,\Omega$ -cm. Most of the TCOs are n-type semiconductors. The electrical conductivity of n-type TCO thin solid films depends on the electron density in the conduction band and on their mobility: σ =mne, where μ is the electron mobility, n is its density, and e is the electron charge. The mobility is given by:

$$\mu = \frac{e\tau}{m*}$$

where τ is the mean time between collisions, and m* is the effective electron mass. However, as n and τ are negatively correlated, the magnitude of μ is limited. Due to the large energy gap (Eg > 3 eV) separating the valence band from the conducting band, the conduction band cannot be thermally populated at room temperature (kT~0.03 eV, where k is Boltzmann's constant), hence, stoichiometric crystalline TCOs are good insulators [7]. To explain the TCO characteristics, various population mechanisms and several models describing the electron mobility were proposed. Some characteristics of the mobility and the processes by which the conduction band is populated with electrons were shown to be interconnected by electronic structure studies [8] e.g., that the mobility is proportional to the magnitude of the band gap.

In the case of intrinsic materials, the density of conducting electrons has often been attributed to the presence of unintentionally

introduced donor centers, usually identified as metallic interstitials or oxygen vacancies that produced shallow donor or impurity states located close to the conduction band. The excess or donor electrons are thermally ionized at room temperature and move into the host conduction band. However, experiments have been inconclusive as to which of the possible dopants was the predominant donor [9]. Extrinsic dopants have an important role in populating the conduction band, and some of them have been unintentionally introduce. Thus, it has been conjectured in the case of ZnO that interstitial hydrogen, in the H⁺ donor state, could be responsible for the presence of carrier electrons [10]. In the case of SnO₂, the important role of interstitial Sn in populating the conducting band, in addition to that of oxygen vacancies, was conclusively supported by first-principle calculations of Kilic and Zunger [11].

They showed that Sn interstitials and O vacancies, which dominated the defect structure of SnO2 due to the multivalence of Sn, explained the natural nonstoichiometry of this material and produced shallow donor levels, turning the material into an intrinsic n-type semiconductor [10]. The electrons released by these defects were not compensated because acceptor-like intrinsic defects consisting of Sn voids and O interstitials did not form spontaneously. Furthermore, the released electrons did not make direct optical transitions in the visible range due to the large gap between the Fermi level and the energy level of the first unoccupied states. Thus, SnO2 could have a carrier density with minor effects on its transparency [10]. The conductivity σ is intrinsically limited for two reasons. First, n and μ cannot be independently increased for practical TCOs with relatively high carrier concentrations. At high conducting electron density, carrier transport is limited primarily by ionized impurity scattering, i.e., the Coulomb interactions between electrons and the dopants.

Higher doping concentration reduces carrier mobility to a degree that the conductivity is not increased, and it decreases the optical transmission at the near-infrared edge. With increasing dopant concentration, the resistivity reaches a lower limit, and does not decrease beyond it, whereas the optical window becomes narrower. Bellingham et al. were the first to report that the mobility and hence the resistivity of transparent conductive oxides (ITO, SnO2, ZnO) are limited by ionized impurity scattering for carrier concentrations above 10²⁰cm⁻³. Ellmer also showed that in ZnO films deposited by various methods, the resistivity and mobility were nearly independent of the deposition method and limited to about 2×10-4 Wcm and 50 cm²/Vs, respectively [12,13]. In ITO films, the maximum carrier concentration was about 1.5×10^{21} cm⁻³, and the same conductivity and mobility limits also held [14]. This phenomenon is a universal property of other semiconductors. Scattering by the ionized dopant atoms that are homogeneously

distributed in the semiconductor is only one of the possible effects that reduces the mobility [15,16].

The all recently developed TCO materials, including doped and undoped binary, ternary, and quaternary compounds, also suffer from the same limitations. Only some exceptional samples had a resistivity of $\leq 1 \times 10^{-4}$ Wcm. In addition to the above-mentioned effects that limit the conductivity, high dopant concentration could lead to clustering of the dopant ions [17], which increases significantly the scattering rate, and it could also produce nonparabolicity of the conduction band, which has to be taken into account for degenerately doped semiconductors with filled conduction bands [18].

Optical Properties

As mentioned above, besides high conductivity (\sim 106 S), effective TCO thin solid films should have a very low absorption coefficient in the near UV-VIS-NIR region. The transmission in the near UV is limited by E_g , as photons with energy larger than E_g are absorbed. A second transmission edge exists at the NIR region, mainly due to reflection at the plasma frequency. Ideally, a wide band gap TCO should not absorb photons in the transmission "window" in the UV-VIS-NIR region. However, there are no "ideal" TCOs thin solid films, and even if such films could be deposited, reflection and interference would also affect the transmission. Hence, 100% transparency over a wide region cannot be obtained.

The optical properties of TCOs transmission T, reflection R, and absorption A, are determined by its refraction index n, extinction coefficient k, band gap $E_{\rm g}$, and geometry. Geometry includes film thickness, thickness uniformity, and film surface roughness. T, R and A are intrinsic, depending on the chemical composition and solid structure of the material, whereas the geometry is extrinsic. There is a negative correlation between the carrier density and the position of the IR absorption edge, but positive correlation between the carrier density and the UV absorption edge, as $E_{\rm g}$ increases at larger carrier density (Moss-Burstein effect). As a result, the TCO transmission boundaries and conductivity are interconnected.

The width of the VIS transmission window of a TCO film with thickness deposited on a transparent substrate is affected not only by the optical parameters of the TCO film but also by the optical properties of the substrate. The refractive index n_{sub} of the most common substrates are $\sim\!1.45$ for fused silica and $\sim\!1.6$ for various glasses. The extinction coefficient of the substrate (k_{sub}) is generally $<10^{-7}$, hence any light absorption would take place in the film, where generally $k_{\text{film}}\!\!> k_{\text{sub}}$. For films thicker than 100 nm, several interference bands could be formed, producing maximal and minimal values of T when either the wavelength or thickness is varied. When $k_{\text{film}}\!\!\approx 0$, the peak transmission (T_{max}) is equal to

the transmission of the substrate [19]. Hence, assuming that the sample is in air, T_{max} = 90% and 93% for films deposited on glass and fused silica, respectively. The minimum sample transmission (T_{min}) in air is expressed by:

$$T_{\min} = \frac{4n^2 n_{sub}}{(1+n^2)(n^2 + n_{sub}^2)}$$

As most TCO films have values of n in the VIS in the range 1.8 -2.8, T_{min} will be in the range 0.8 – 0.52. T_{min} is closely approximated by the relation: $T_{min} = 0.051n^2 - 0.545n + 1.654$. As n in the VIS decreases with wavelength, T_{\min} increases with wavelength, but will not exceed ~0.8. When the film extinction coefficient is not negligible and affects the transmission, T_{max} < T_{sub} , and T_{min} also decreases. By decreasing the TCO film thickness, T is increased but the sheet resistance decreases. Combining together the optical and electrical properties of the film, the fraction of the flux absorbed in a film (A) is given by the expression:

$$A \cong 1 - \exp^{-\frac{\alpha}{\sigma R}}$$

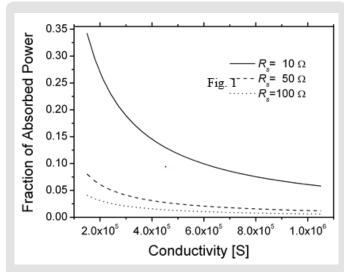
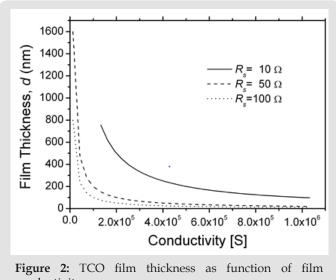


Figure 1: Fraction of absorbed power as function of TCO conductivity.

Figure 1 presents plots of the fraction of the absorbed power at wavelength of 400nm and k \sim 0.02 as a function of the conductivity for three representative values of RS. For a given σ , low values of RS necessitate using thick films, and lower conductivity requires the use of even thicker films, resulting in an increase in the loss of radiative power. The dependence of film thickness on the conductivity for three values of Rs is presented in Figure 2. Using the same film conductivity, applications requiring the lowest RS will be thicker and, and the absorbed fraction will be higher. At present, only high-quality ITO is compatible at present with the

condition that the absorbed power fraction be lower than 10% and RS = 10Ω At lower extinction coefficient (k) films with lower conductivities can be used, e.g., when k = 0.002 instead of 0.02, the absorbed power A is lower by a factor of ~8 and allows the use of thicker films. The combination of film thickness, conductivity, and extinction coefficient determine the absorption of the radiation flux. However, when the total transmission T is considered, reflection and interference must be considered, which depend on the refractive indices of the substrate and the film, and the film thickness. A general formula for T and R was given by Cisneros [20].



conductivity.

Trends in the Development of TCO Materials

While the development of new TCO materials is mostly dictated by the requirements of specific applications, low resistivity and low optical absorption are always significant pre-requisites. There are basically two strategies in managing the task of developing advanced TCOs that could satisfy the requirements. The main strategy dopes known binary TCOs with other elements, which can increase the density of conducting electrons. As shown in Table 1, more than 20 different doped binary TCOs were produced and characterized [21], of which ITO was preferred, while AZO and GZO come close to it in their electrical and optical performance. Doping with low metallic ion concentration generates shallow donor levels, forming a carrier population at room temperature. Doping In₂O₂ with Sn to form ITO substantially increased conductivity. It is believed that substituting Sn4+ for In3+ provides carrier electrons, as Sn4⁺ is supposed to act as a one-electron donor [22]. Similarly, aluminum is often used for intentional n-type doping of ZnO, but other group III impurities, such as Ga and In, and group IV, such as Sn and Ge, also work.

Table 1: TCO Compounds and Dopants.

TCO	Dopant
SnO ₂	Sb, F, As, Nb, Ta
ZnO	Al, Ga, B, In, Y, Sc, F, V, Si, Ge,Ti, Zr, Hf, Mg, As, H
In ₂ O ₃	Sn, Mo,Ta, W, Zr, F, Ge, Nb, Hf, Mg
CdO	In, Sn
Ta ₂ O	
GaInO ₃	Sn, Ge
CdSb ₂ O ₃	Y

Doping by Al produced the relatively high conductivity AZO.3 Doping with non-metallic elements is also common, e.g., ZnO:Ge (GZO), SnO₂:F (FTO) and SnO₂:Sb (ATO) [23,24]. Recently, AZO films with resistivity r~8.5.10⁻⁵ Wcm was reported by Agura, et al. [25]. An even lower resistivity was reported for GZO, \sim 8.1. 10^{-5} Wcm [26]. This ρ is very close to the lowest resistivity of ITO [27] of 7.7·10⁻⁵ Wcm, with a free carrier density of 2.5.10²¹ cm⁻³. The above-described metallic dopant ions should have appropriate valency to be an effective donor when replacing the native metallic ion. However, when an O2- ion is replaced with a F- ion, a donor level is again produced. Thus, doping SnO2 by F increased the carrier electron mobility by a factor of \sim 2 and their concentration also by a factor of 2, reducing the resistivity by a factor of 4 [28]. The concentration of F- dopant ions should not exceed an upper limit, as an increase in carrier scattering by F ions led to a decrease in the conductivity [29]. Doping SnO₂ with Sb initially introduces Sb⁵⁺ions that act as donors. When the doping concentration was increased beyond a certain level, however, Sb³⁺ ions began to replace the Sn⁴⁺ ions.

The introduction of Sb3+ ions generates an acceptor level that compensates the donors and increases the resistivity [30-34]. This effort to increase the conductivity without degrading the transparency was paralleled by a more elaborate strategy in which phase-segregated two-binary and ternary TCOs were synthesized and characterized. The phase-segregated two-binary systems include ZnO-SnO₂, CdO-SnO₂, and ZnO-In₂O₂. In spite of the expectations, the electrical and optical properties of the twobinary TCOs were much inferior to those of ITO. The phase diagram of the ternary TCOs could be schematically presented by a threedimensional or four-dimensional phase combination of the most common ternary TCO materials [20,30] based on known binary TCO compounds. Accordingly, the ternary TCO compounds could be formed by combining ZnO, CdO, SnO₂, InO₁₅ and GaO₁₅ to obtain Zn₂SnO₄, ZnSnO₅, CdSnO₄, ZnGa₂O₄, GaInO₅, Zn₂In₂O₅, Zn₃In₂O₆, and Zn₄In₂O₇. However, as Cd and its compounds are highly toxic, the utilization of these TCOs is limited, though they have adequate electrical and optical properties.

Other binary TCOs were synthesized from known binary TCOs and also from non-TCO compounds, such as In₆WO₁₂ and the p-type CuAlO₂. The first-principle model of Kiliç and Zunger,10 showed the importance of the composition in turning an insulating oxide into a TCO. However, structural considerations should also be included. Hosono et al [31]. investigated the conditions for depositing widegap amorphous oxides with high electron mobility. They indicated that since the mobility is proportional to the width of the conduction bands, a large overlap between relevant orbitals is required. In addition, the magnitude of the overlap needs to be insensitive to the structural randomness that is intrinsic to the amorphous state. They assumed that since the spatial spreading of the ns orbital is large and the overlap between these ns orbitals with spherical symmetry is large and insensitive to any angular variations in the M-O-M bonds (where M is a metal cation) compared with p-p or d-p orbitals having high anisotropy in geometry.

Oxides composed of metal cations with an electronic configuration (n-l)d10ns0 would satisfy these requirements, as the lowest part of the conduction band in these oxides is primarily composed of ns orbitals [32]. Hosono et al. also conjectured that because of this, ternary oxides are preferred to binary oxides for the formation of amorphous TCO thin solid films. Scanning the periodic table, they identified 105 combinations of elements as promising ternary oxide candidates. As indicated by Mizoguchi and Woodward,7 not only do binary n-type TCO materials contain a metal with (n-1)d10ns0electronic configuration, but also the ternary and quaternary complex TCOs. In a study of CdSnO2, Cd2SnO4, and CdIn₂O₄, Shannon et al. conjectured that the formation of a transparent conductor could result from edge sharing of Cd2+, In3+, and Sn4+ octahedra [33]. Nearly all of the complex TCOs found to date possess cations in octahedral coordination, as do most binary TCOs, with the exception of ZnO (wurtzite structure) and β -Ga₂O₂.

These and other studies show that similar complex oxides may be a rich source of new TCO materials [34-37]. Mizoguchi and Woodward concluded, however, that based on their research the only necessary condition for an oxide, binary or complex, to be a transparent conductor was to have a structure causing the lowest energy band to be dispersed and split off from the rest of the conduction band, whereas continuous edge sharing of the structural octahedra is only accidental [7]. The lowest energy band in the conduction band of an effective transparent conductor should be wide so that carriers introduced upon doping will be highly mobile. This condition is met when the anion coordination environment is fairly symmetric, as is the case in binary TCOs. This is a necessary but not sufficient condition for transparent conductivity. The second condition for a good TCO material is that it

must be possible to effectively populate the conduction (or valence) band by doping, and that the doping should not seriously degrade the carrier mobility or the optical transmission [7,22].

Considering the ternary TCO compound (A_M_O_), where A is a lower valency cation and M is a main group ion with higher valency, if the valance of the A-O and M-O interactions were not too different, as they would be when the A-cation has an (n-1)d10ns0 electron configuration, the oxygen bonding was likely to remain reasonably symmetric and a disperse conduction band would result, in agreement with the necessary condition specified above. The dispersion of the conduction band energy in such compounds may not be as large as in a binary oxide, yet there could be extra freedom to manipulate the composition and structure of such oxides, facilitating the adaptation of the electronic energy levels for applications with specific needs [7]. All of the TCOs discussed above are n-type semiconductors. In addition, p-type doped TCOs were also developed and could find interesting future applications, in particular in the new optoelectronic field of "transparent electronics" [38]. Fabricating undoped or doped p-type TCOs was found to be more difficult than the n-type.

The first p-type TCO was made from CuAlO, by Kawazoe in 1997 [39]. Prior to this, however, in 1993 Sato et al. reported on a semi-transparent p-type TCO with ~40% visible transmission [40]. It has been reported that is possible to form acceptor levels in ZnO, doping with N, P and As. The difficulty in producing p-type oxide was hypothesized to result from the strong localization of holes at oxygen 2p levels or due to the ionicity of the metallic atoms. O 2p levels are far lower lying than the valence orbit of metallic atoms, leading to the formation of a deep acceptor level with the holes. Hence, these holes are localized and require sufficiently high energy to overcome a large barrier height in order to migrate within the crystal lattice, resulting in poor hole-mobility and conductivity [41,42]. Following this hypothesis, an effort was made to grow p-type TCO based on "Chemical Modulation of the Valence Band (CMVB)", where the oxide composition and structure were expected to delocalize the holes in the valence band.

The recent detailed report of Benerjee and Chattopadhyay [35] lists several groups of such synthesized p-type TCOs, e.g., $\text{CuM}^{\text{iii}}\text{O}_2$, $\text{AgM}^{\text{iii}}\text{O}_2$ where M^{iii} is a trivalent ion. Compared with the n-type TCOs, these TCO have relatively lower conductivities, of the order of 1 S/cm, and lower transmission, < 80%. Growing p-ZnO was an important milestone in "Transparent Electronics", allowing fabrication of wide band gap p-n homo-junctions, which is a key structure in this field. It was anticipated that higher conductivity and optical transmission could be obtained by doping ZnO with N, F, P, Sb, and As, however, it was also shown that such doping had some serious limitations [43,44]. Based on first principle calculations, Yamamoto and Yoshida [45] proposed that co-doping of donor-

acceptor dopants (e.g. Ga and N, respectively) in ZnO might lead to p-type ZnO. Joseph et al. applied this principle to simultaneously dope ZnO with an acceptor (N) and a donor (Ga), where the acceptor concentration was twice that of the donor.

The optical transmission was greater than 85%, but the conductivity was low, ~1 S/cm [46]. p-type ZnO:Sb was deposited with a filtered vacuum arc equipped with a Zn cathode doped by Sb [47]. The conductivity was ~0.5 S/cm, the mobility 9-20cm²/ Vs and the hole density ~ 4.1016 cm⁻³, with transmission of $\sim 85\%$. It is evident that the challenge to grow p-type TCO with $\rho \sim 10^{-3}$ Ω .cm, or better, still exists. The need to produce n-type TCOs with higher conductivity and better transmission, without relying on In, inspired research and development effort to discover and study some unconventional TCOs. Novel transparent conductors were proposed using oxides with s2 electron configurations. Oxides of Mg, Ca, Sc and Al also exhibited the desired optical and electronic features; however, they have not been considered as candidates for achieving good electrical conductivity because of the challenge of efficiently generating carriers in these wide band gap materials. The approach suggested was to increase the mobility rather than the carrier density.

If this goal could be achieved, the optical properties would not deteriorate at lower resistivity. Recently, mobility with more than twice that of commercial ITO was observed in Mo-doped In203 (IMO), and it was shown that the conductivity can be significantly increased with no changes in the spectral transmittance upon doping with Mo [48,49], Electronic band structure investigations of IMO by Medvedeva revealed that the magnetic interactions which had never been considered to play a role in combining optical transparency with electrical conductivity ensure both high carrier mobility and low optical absorption in the visible range [50]. Recently, new thin film geometries were also explored in search of TCO films with higher conductivity. Dingle, et al [51]. showed that higher conductivity could be obtained by doping modulation, which spatially separates the conduction electrons and their parent impurity atoms (ions) and thereby reduced the effect of ionized and impurity scattering on the electron motion.

Rauf [52] used a zone confining process to deposit ITO with ρ = 4.4·10⁻⁵ Ω .cm and μ = 103 cm²/Vs. The highly and lowly doped regions were laterally arranged in the films, rather than vertically as in superlattice structures. A theoretical outline of a method to engineer high mobility TCOs was presented by Robbins and Wolden [53], based on the high mobility transistor structure discovered accidentally by Tuttle, et al. [54]. The film should consist of alternating thin layers of two semiconductors. One layer provides a high density of carriers, while the second is a high mobility material. Electrons are supplied by the former and transported in the latter, mitigating the limitations of ionized impurity scattering

[50]. The model of Robbins and Wolden assumes that the electrons move into the high mobility material in response to differences in electron affinity.50 However, the success of the proposed TCO design depends upon controlling the layer thickness at nano dimensions, (e.g. \sim 5 nm).

In addition, this approach depends on having materials of excellent quality and compatible crystal structure in order to avoid problems related to interface defects. TCO materials with magnetic properties, which are ferromagnetic semiconductors with a Curie temperature well above room temperature, have also been explored recently, as they could be used for second generation spin electronics and as transparent ferromagnets. reported that Co doped ZnO thin film ($Z_{n1-x}Co_xO$) with x=0.05-0.25, had a large magnetic moment of $1.8\mu B$ per Co ion for x=0.05. High-temperature ferromagnetism was subsequently found by other groups, with varying magnetic moments.

Industrial Application of TCOs

TCO's have diverse industrial applications - some of the more important ones will be described in this section. TCO coatings are applied to transparent materials used for work surfaces and closet doors, particularly in clean rooms used for electronics assembly, in order to prevent harmful static charge buildup. In this application relatively high surface resistances (e.g. $k\Omega/\Box$) can be tolerated. Transparent heating elements may be constructed from TCO coatings. These are applied as defrosters in aircraft and vehicular windshields. Their advantage over traditional hot air blowers is that they can have a much shorter effective defrosting time, and work uniformly over large areas. This application requires either the use of very low surface resistance coatings (e.g. $\sim 1 \Omega/\Box$)), or a high voltage power source. The application of TCO coatings to passenger vehicles has proven to be technically successful but a commercial failure, due to the high cost of a supplemental alternator to deliver the requisite high voltage. If the automobile industry will adopt a higher bus voltage, as has been widely discussed, then this application may prove to be more commercially feasible in the future.

TCO coatings may be used as shielding to decrease electromagnetic radiation interference (EMI) from providing visual access. This may be to either to keep radiation from escaping an enclosure, to avoid interfering with nearby devices, or detection, or from entering an enclosure to prevent external radiation sources from interfering with electronic devices within. One potential example is the window of domestic microwave ovens, which today use a perforated metal screen, which obscures clear visual observation, to reduce microwave leakage. Radiation leakage must be minimized to prevent harm to the users, as well as interference to proliferating wireless devices which use the unlicensed spectral band at 2.45 GHz. While transparent conducting films

were proposed 50 years ago, an attempt to introduce microwave windows with TCO coatings into the market was not successful about a decade ago, due to the high cost. Low-cost designs are currently being developed.

The three largest applications of transparent conductive oxide thin solid films, in terms of the surface area covered, and their total value, are flat panel displays, solar cells, and coatings on architectural glass. In general, transparent electrodes are needed for a large variety of electro-optical devices, of which flat panel displays and solar cells are the most important examples. In liquid crystal displays (LCDs), TCO films are needed for both electrodes, in order to allow backlighting to pass through the liquid crystal film while applying voltage to the various pixels. Generally, these electrodes are in the form of a pattern of lines, with the alignment of the lines on the two electrodes perpendicular to each other. This allows addressing individual pixels by applying a voltage to the two lines which intersect at a given pixel. Thus, patterning the films is required. ITO is the TCO of choice in this application, both because of its electro-optical properties, and the relative ease of acid etching.

The best LCDs utilize an active matrix comprising one amorphous silicon transistor which occupies a corner of each pixel, and because the silicon is opaque, has reduced light transmission. Recently transparent field effect transistors (FETs) have been developed based on the zinc oxide but using a Cr gate. These zinc oxide FETs have been incorporated into small 220X280 10µm pixel active-matrix LCDs. Small and medium LCDs are a 25 B\$/yr market which is growing by about 5%/yr, while large area LCDs have a similar market size and a much higher growth. The explosive growth for demand of ITO coatings for this specific application has generated widespread concern about Indium scarcity in the near future. Most solar cells use TCO films as a transparent electrode. Major considerations in the choice of the TCO for this application, besides the conductivity and transparency, are electronic compatibility with adjacent layers in the cell, processing requirements, and stability under environmental conditions.

Often tin oxide-based films are chosen for this application, in as much as patterning is not required, but environmental stability is. TCO films are commonly applied to architectural glass, often as part of multi-layer stacks. In window glass applications, usually the conductivity per se is irrelevant, but rather the concurrent high infra-red reflectivity is exploited, in order to obtain good light transmission in the visible range, while minimizing heat transmission. This feature is used to minimize air conditioning costs in the summer, and heating costs in the winter, in buildings equipped with appropriately coated windows. Approximately 25% of flat glass is coated, and energy conserving coatings are now mandated in various regions. Most commonly the coatings are applied by two techniques.

- (1) Very enduring and inexpensive, but simple, coatings are produced with atmospheric pressure chemical vapor deposition (APCVD), in line with the float glass production process. This insures a fresh surface and exploits the high temperature of the glass during its production. However, APCVD is not very flexible and there are only limited options available for the coating architecture.
- (2) A more flexible, but also more costly, process is magnetron sputtering. Commonly multiple (e.g. 20-60) rotary targets are mounted in long modular vacuum systems (e.g. 40-160 m length), and multilayer stacks are deposited as the glass panels pass beneath the various cathodes, traveling at velocities of ~1 m/s. Typically these systems operate continuously for 2 weeks, after which expended targets are replaced and other maintenance is performed.

Commercial Availability of TCO Thin Solid Films

The coating industry is segmented into "captive shops" which provide coating service within a given company for their products, and "job shops" which provide contract coating services for external companies. It is difficult to gather information about the former, since companies have no need to advertise their captive shops, and often prefer to guard their processes as trade secrets. More information is available concerning TCO availability from job shops, who often advertise their capabilities via the internet. A survey of these companies revealed that about \% of them indicated that they provide ITO coatings; most of the remainder did not specify the coating composition, but most probably they also deposit ITO as their TCO of choice. Only one company advertised supplying FTO films, and another also advertised IZO and AZO. Surface resistances ranged from 5 to $500\Omega/\Box$. It should also be noted that float glass online coated by APCVD with FTO is readily available as an inexpensive commodity.

Conclusion

The expanding use of TCO materials, especially for the production of transparent electrodes for optoelectronic device applications, has developed into a worldwide multi-billion \$US economy that in general depends on the availability of ITO. This economy is endangered by the scarcity and high price of In. The situation drives the search for alternative TCO materials to replace ITO and motivates an intensive investigation of the physics and chemistry of TCO materials. The main significant progress in the research and development of TCO thin solid films has been made in understanding the physics of TCO semiconductors. The physical processes that make possible the coexistence of electrical conductivity and optical transparency are well clarified and understood. In particular, the role of oxygen vacancies and

various dopants in the formation of shallow donor levels is well established. In addition to binary TCOs, progress has also been made in developing new TCO compounds, consisting of combined segregated-binaries, ternary and quaternary oxides.

However, the objective of developing new TCOs with conductivity similar or even higher than that of ITO has not been realized. The conductivity of the recently developed ternary, quaternary, and binary-combination TCOs is lower than that of ITO. It is now appreciated that the attainment of higher conductivity is limited by the negative correlation between carrier density and electron mobility. It is now realized that the development of TCOs with higher conductivity does not necessarily depend on higher dopant concentration that provides higher carrier density but could also be achieved by maintaining moderate carrier density with increased mobility. Spatial separation of the conduction electrons and their parent impurity atoms (ions) should significantly reduce carriers scattering and increase their mobility. Using this principle, the conductivity of ITO was successfully increased, however, it has not yet been applied to other TCOs. The effort to produce TCOs with higher mobility based on using the oxides with ns2 electron configuration, instead of the ns0 electron configurations found in typical TCOs, was only partially successful.

These wide band gap oxides exhibited the desired optical and electronic features; however, their conduction was low due to too low. p-type TCOs were obtained by doping ZnO with N, F, P, Sb, and As, however, it was also shown that such doping had some serious limitations, and the conductivity was lower than n-type ZnO. In summary, AZO, GZO and FTO are at present the only TCOs with electrical conductivity close to that of ITO, and with appropriate high optical transmission in the near-UV, VIS and NIR. The objective of producing TCO materials with optical and electrical characteristics equivalent to those of ITO has not yet been achieved.

Conflicts of Interest

The authors declare no conflict of interest.

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